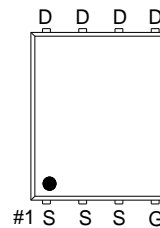
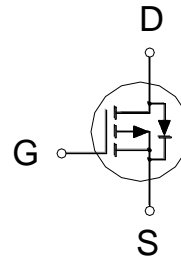




PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
-30V	7mΩ	-70A



G : GATE
D : DRAIN
S : SOURCE

Features

- Pb-Free, Halogen Free and RoHS compliant.
- Low $R_{DS(on)}$ to Minimize Conduction Losses.
- Ohmic Region Good $R_{DS(on)}$ Ratio.
- Optimized Gate Charge to Minimize Switching Losses.
- ESD Protected up to 2KV.

Applications

- Protection Circuits Applications.
- Logic/Load Switch Circuits Applications.

ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ °C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		V_{DS}	-30	V
Gate-Source Voltage		V_{GS}	±25	V
Continuous Drain Current	$T_C = 25\text{ °C}$	I_D	-70	A
	$T_C = 100\text{ °C}$		-44	
	$T_A = 25\text{ °C}$		-16	
	$T_A = 70\text{ °C}$		-13	
Pulsed Drain Current ¹		I_{DM}	-110	
Avalanche Current		I_{AS}	-38	
Avalanche Energy	L = 0.1mH	E_{AS}	72	mJ
Power Dissipation	$T_C = 25\text{ °C}$	P_D	59	W
	$T_C = 100\text{ °C}$		23	
	$T_A = 25\text{ °C}$		3.2	
	$T_A = 70\text{ °C}$		2	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE		SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$t \leq 10s$			39	°C / W
	Steady-State	$R_{\theta JA}$		56	
Junction-to-Case		$R_{\theta JC}$		2.1	

¹Pulse width limited by maximum junction temperature.

²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ C$. The value in any given application depends on the user's specific board design.

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ C$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT		
			MIN	TYP	MAX			
STATIC								
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-30			V		
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-1	-1.5	-3			
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 25V$			± 100	nA		
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -24V, V_{GS} = 0V$			-1	uA		
		$V_{DS} = -20V, V_{GS} = 0V, T_J = 125^\circ C$			-10			
Drain-Source On-State Resistance ¹	$R_{DS(ON)}$	$V_{GS} = -4.5V, I_D = -13A$		8.4	12	mΩ		
		$V_{GS} = -10V, I_D = -13A$		5.7	7			
Forward Transconductance ¹	g_{fs}	$V_{DS} = -5V, I_D = -13A$		40		S		
DYNAMIC								
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = -15V, f = 1MHz$		2822		pF		
Output Capacitance	C_{oss}			452				
Reverse Transfer Capacitance	C_{rss}			364				
Gate Resistance	R_g	$V_{GS} = 0V, V_{DS} = 0V, f = 1MHz$		4		Ω		
Total Gate Charge ²	$Q_{g(VGS=-10V)}$	$V_{DS} = -15V, I_D = -13A$		60		nC		
	$Q_{g(VGS=-4.5V)}$			30				
Gate-Source Charge ²	Q_{gs}			6.1				
Gate-Drain Charge ²	Q_{gd}			14				
Turn-On Delay Time ²	$t_{d(on)}$		$V_{DS} = -15V, I_D \cong -13A, V_{GS} = -10V, R_{GS} = 6\Omega$		39			nS
Rise Time ²	t_r				26			
Turn-Off Delay Time ²	$t_{d(off)}$				161			
Fall Time ²	t_f			100				

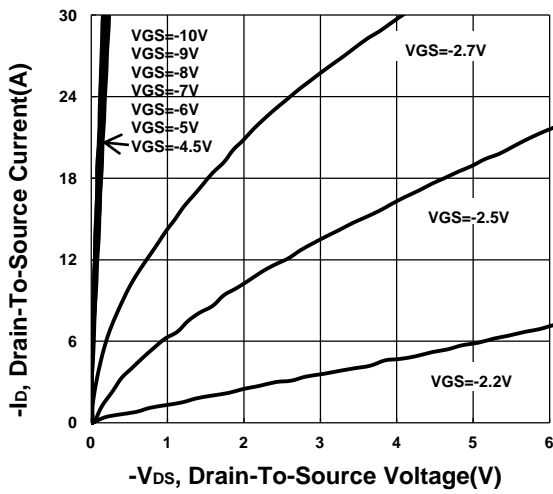
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T_J = 25 °C)

Continuous Current	I _S				-49	A
Forward Voltage ¹	V _{SD}	I _F = -13A, V _{GS} = 0V			-1.3	V
Reverse Recovery Time	t _{rr}	I _F = -13A , di _F /dt = 100 A / μS		23		nS
Reverse Recovery Charge	Q _{rr}			6		nC

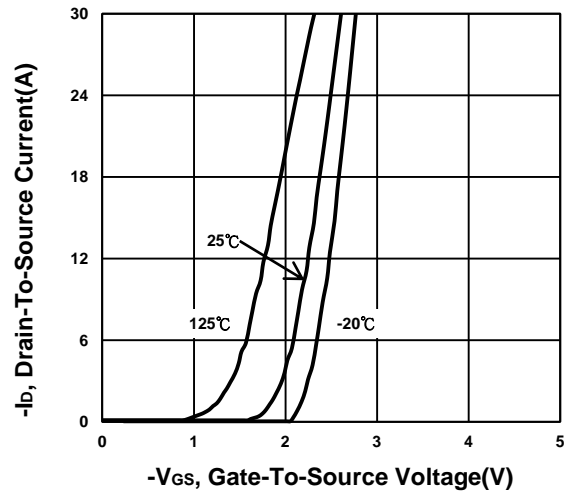
¹Pulse test : Pulse Width ≤ 300 μsec, Duty Cycle ≤ 2%.

²Independent of operating temperature.

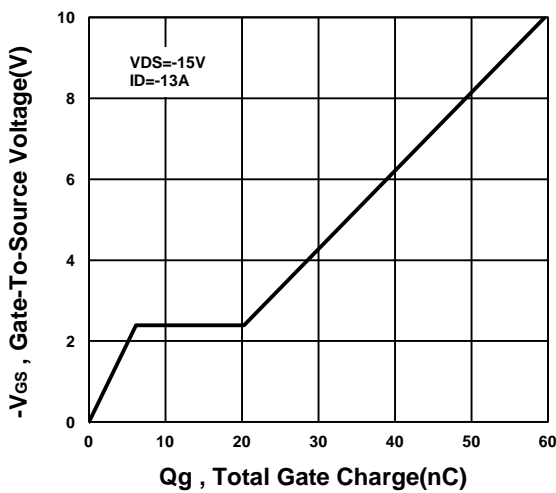
Output Characteristics



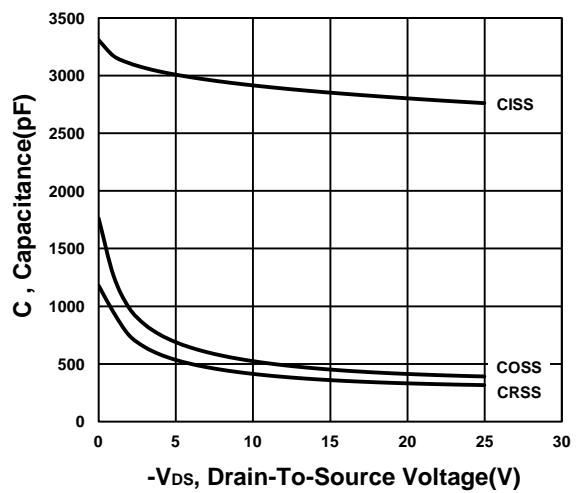
Transfer Characteristics



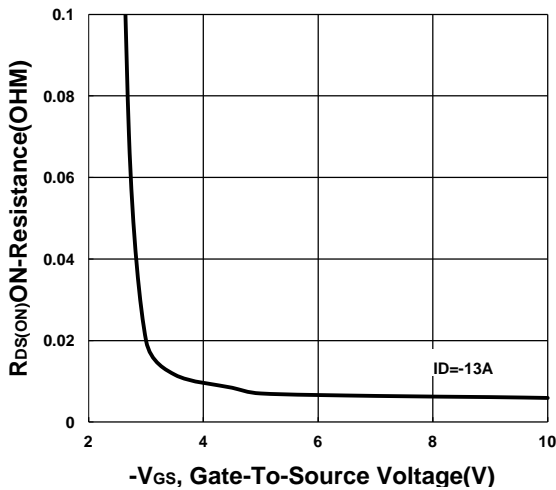
Gate charge Characteristics



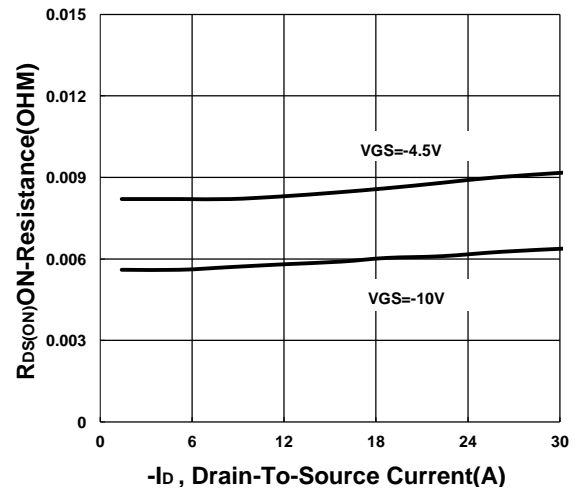
Capacitance Characteristic



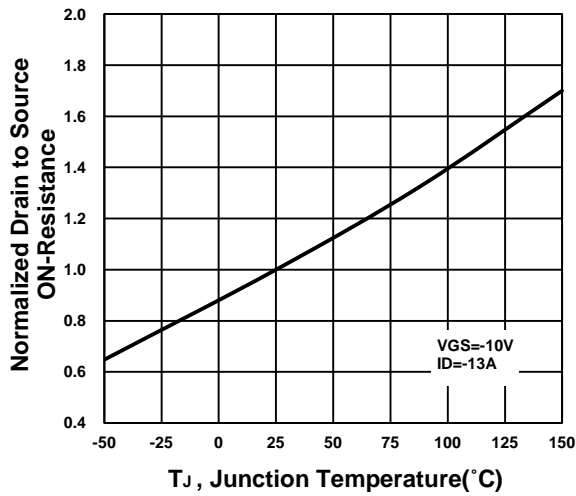
On-Resistance VS Gate-To-Source



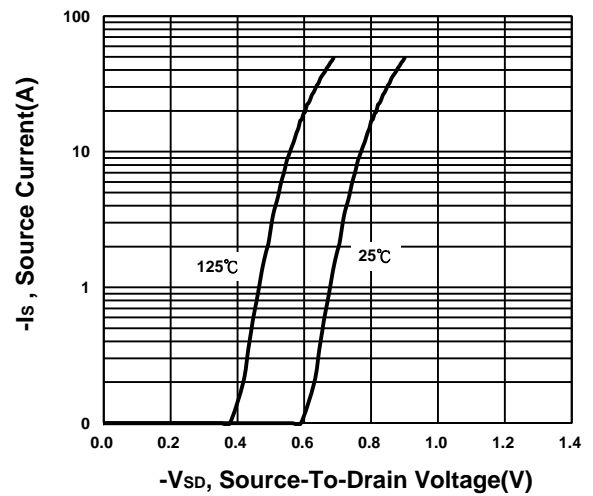
On-Resistance VS Drain Current



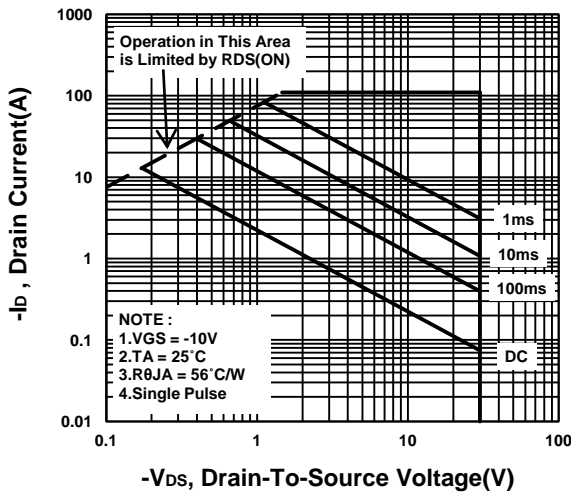
On-Resistance VS Temperature



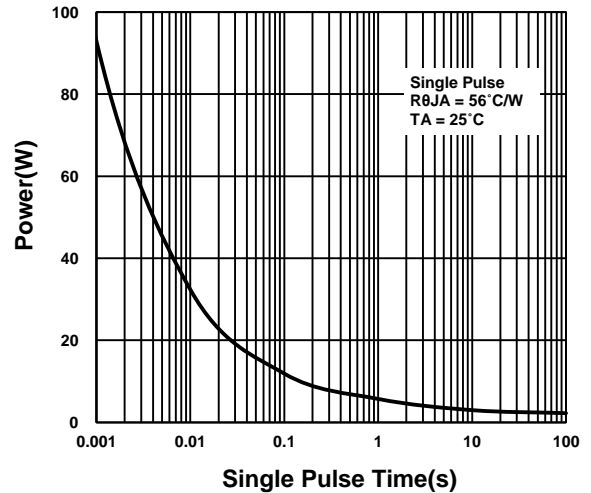
Source-Drain Diode Forward Voltage



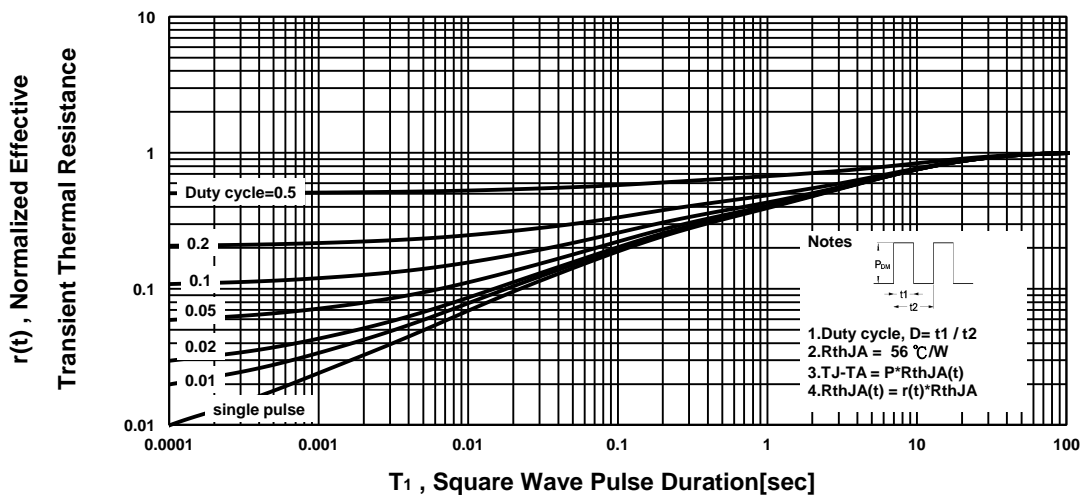
Safe Operating Area



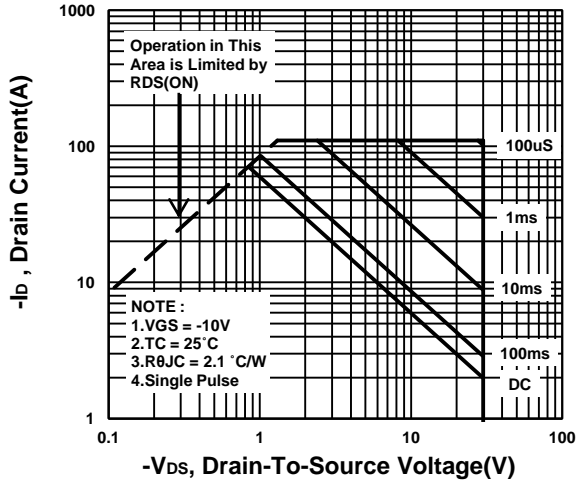
Single Pulse Maximum Power Dissipation



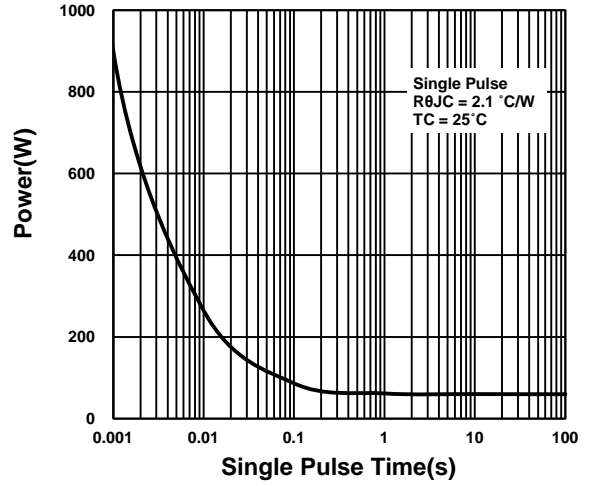
Transient Thermal Response Curve



Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

